



Features

- Formerly a JENSEN+DEVICES product
- Fast switching rate
- High energy, low loss capability
- Wide operating temperature range
- Long service life
- High insulation resistance
- RoHS compliant*

Applications

- Igniters for architectural and automotive Xenon discharge lamps
- Electronic igniters for gas heating and gas domestic appliances, e.g., cookers
- Ignition of ultra-high pressure gas discharge lamps for data and video projectors

Sparcube™ Switching Spark Gap ST-0840 Series

Description

Bourns® Sparcube™ Switching Spark Gap Series is a range of switching spark gaps designed specifically for voltage controlled switching of capacitive discharge circuits where a high energy, low loss, fast rate of switching is required. This series is ideally suited for applications where a capacitive discharge is utilized with a transformer to obtain pulses of very high voltage levels in the order of several thousand volts.

Characteristics

Initial Values:

Static Breakdown Voltage @ 800 V/s ¹

First Ignition Values	< 950 V
Following Ignition Values	740 V to 940 V

Electrical Life:

Minimum Number of Switching Cycles	2x10 ⁵
Peak Current	Approx. 450 A
Maximum Switching Frequency	500 Hz
Breakdown Characteristics @ 1000 V Limit	
First Ignition Values	≤ 1000 V
Delay Time	< 60 ms
Following Ignition Values	720 V to 960 V

General Data:

Breakdown Time	< 50 ns
Insulation Resistance @ 100 Vdc	> 100 megohms
Maximum Static Breakdown Voltage @ 100 V/ms	1300 V
Share of Early Ignition Values (< 720 V)	< 1 %
Residual Voltage @ 50 ns	< 300 V
Capacitance	< 1 pF
Operating Temperature Range ²	-40 °C to +170 °C
Storage Temperature Range	-65 °C to +125 °C
Weight	Approx. 2.3 g
Testing	100 %
Robustness of Terminations	IEC 60068-2-21 ³

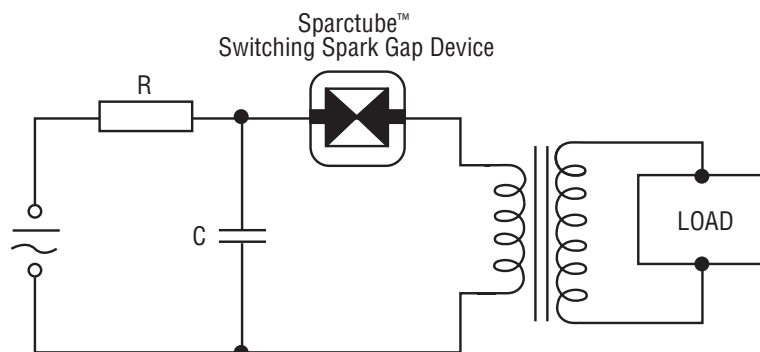
Notes:

¹ At delivery AQL 0.65 Level II, DIN ISO 2859.

² Distribution of switchings: maximum 20 % above +125 °C and 20 % below +20°C.

³ Test Ua1 (tensile), Ua2 (thrust), Ub (bending) and Uc (torsion).

Basic Application Circuit



BOURNS®

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www.bourns.com

*RoHS Directive 2002/95/EC Jan. 27, 2003 including annex and RoHS Recast 2011/65/EU June 8, 2011.

Specifications are subject to change without notice.

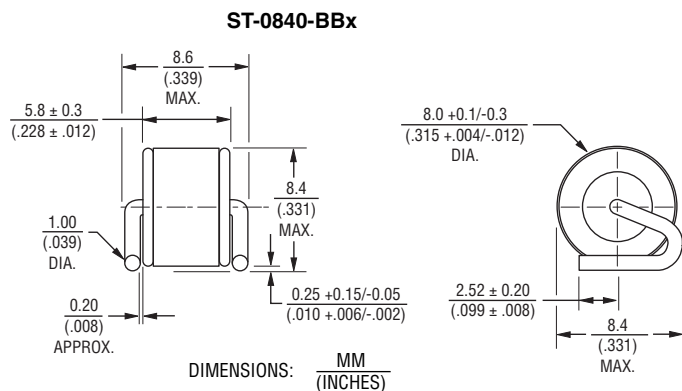
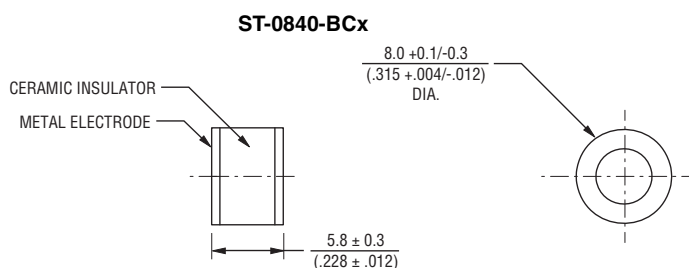
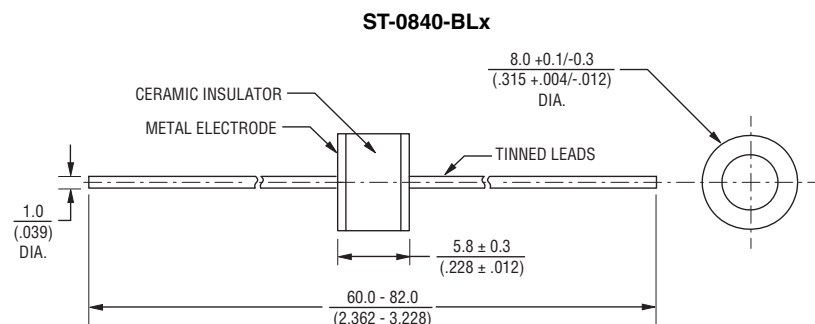
The device characteristics and parameters in this data sheet can and do vary in different applications and actual device performance may vary over time.

Users should verify actual device performance in their specific applications.

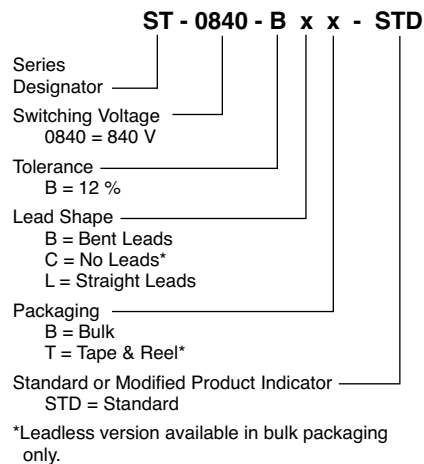
Sparctube™ Switching Spark Gap ST-0840 Series

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Product Dimensions



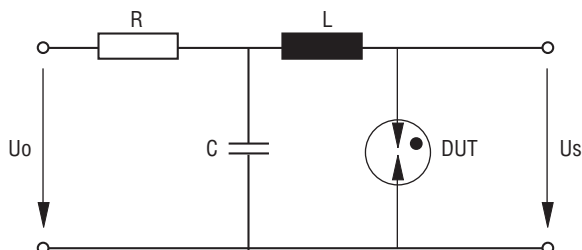
How to Order



Typical Part Marking

B ST 0840 wwyy “wwyy” = Week and year of production

Test Circuit



U_o 1000-1500 V
 R See Note
 C 100 nF
 L 0.5 μ H
DUT Device Under Test
 U_s Breakdown Voltages

NOTE: U_o and R are set to provide suitable conditions for different measurements.

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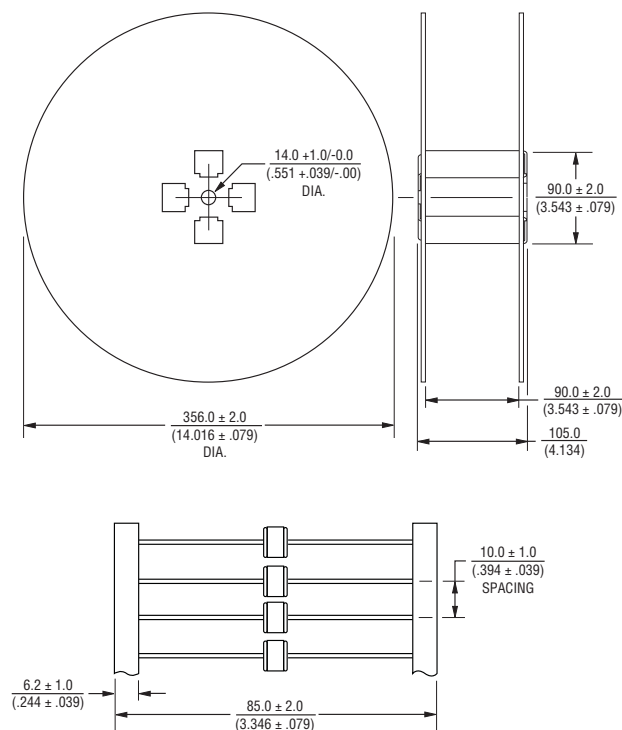
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Packaging Specifications

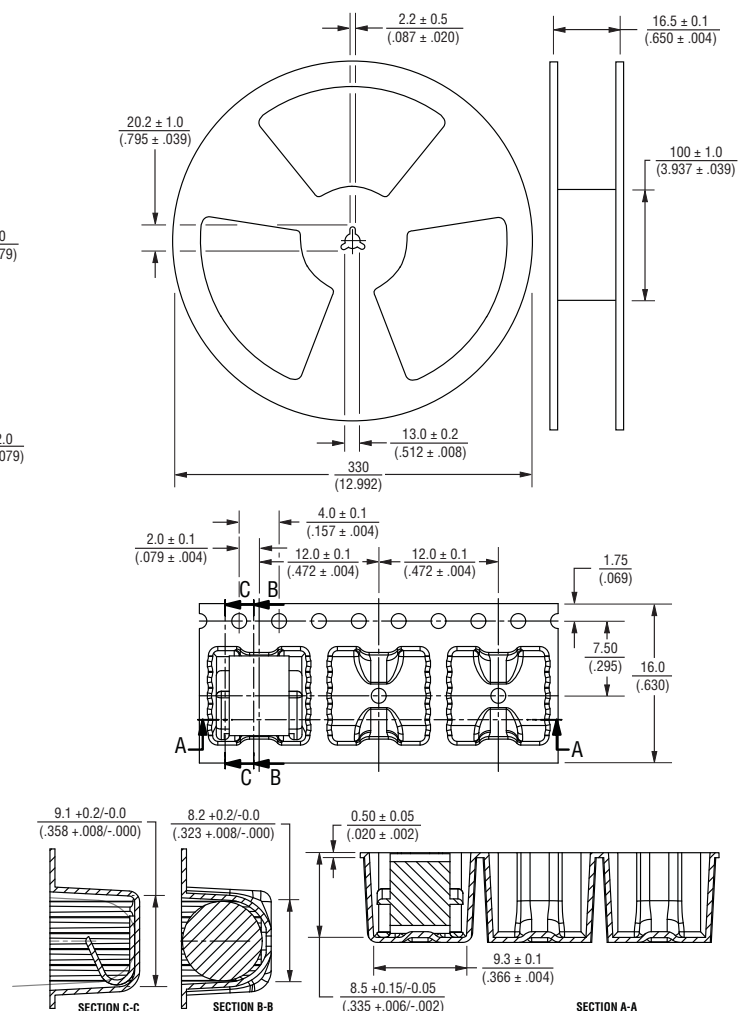
Models ST-0840-BBB, ST-0840-BLB and ST-0840-BCB* ship standard bulk pack, 1,000 pcs./bag. The optional tape and reel packaging contains 1,000 pcs./reel for Model ST-0840-BLT; 500 pcs./reel for Model ST-0840-BBT.

* Available in bulk packaging only.

ST-0840-BLT



ST-0840-BBT



DIMENSIONS: $\frac{\text{MM}}{(\text{INCHES})}$

REV. 04/17/14

"Sparctube" is a registered trademark of Bourns, Inc. in China and the European Community, with a trademark registration application pending in the U.S.

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